

<b>Notice of References Cited</b>				Application No. <b>72533</b>		Applicant(s) <b>Ishikawa</b> <b>Yohrei et al</b>	
				Examiner <b>B. Lee</b>		Group Art Unit <b>2817</b>	
<b>U.S. PATENT DOCUMENTS</b>							
*	DOCUMENT NO.	DATE	NAME			CLASS	SUBCLASS
A	<b>6445255</b>	<b>9/2002</b>	<b>Ishikawa et al</b>			<b>331</b>	<b>107 DP</b>
B	<b>5872485</b>	<b>2/1999</b>	<b>Ishikawa et al</b>			<b>333</b>	<b>250 X</b>
C							
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J							
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<b>FOREIGN PATENT DOCUMENTS</b>							
*	DOCUMENT NO.	DATE	COUNTRY	NAME		CLASS	SUBCLASS
N	<b>735604</b>	<b>10/1996</b>	<b>Europe Pat Off</b>	<b>Ishikawa et al</b>			
O							
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T							
<b>NON-PATENT DOCUMENTS</b>							
*	DOCUMENT (Including Author, Title, Source, and Pertinent Pages)					DATE	
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X							

\* A copy of this reference is not being furnished with this Office action.  
(See Manual of Patent Examining Procedure, Section 707.05(a).)